Flexible circuit board materials **FELIOS**

(Double-sided copper clad) R-F775 (Single-sided copper clad) R-F770

- ■Features
- Excellent dimensional stability
- Line-up of thick copper foil and thick film specifications
- ●Halogen-free with UL94V-0

Application

Various modules for Smartphones and Tablet PCs

■Line-up

●RA Copper Foil

The copper for																	
Copper Foil Thickness		Film Thickness											Unit: mils	s (mm)			
		Sheet Type Max 610mm(MD) x 510mm(TD) Roll Type W=250mm, 500										, 500n	Omm				
		0.5 (0.01)	0.8 (0.02)	1.0 (0.03)	2.0 (0.05)	3.0 (0.08)	4.0 (0.10)	5.0 (0.13)	6.0 (0.15)	0.5 (0.01)	0.8 (0.02)	1.0 (0.03)	2.0 (0.05)	3.0 (0.08)	4.0 (0.10)	5.0 (0.13)	6.0 (0.15)
1/4oz	(9µm)	•	•	_	_	_	_	_	-	_	_	_	_	_	_	_	_
1/3oz	(12µm)						_	_	_		_				_	_	_
1/2oz	(18µm)										_						_
1oz	(35µm)									_	_						_
2oz	$(70\mu m)$	-	_							_	_			_	_	-	_
3oz	(105µm)	_	_	*	*	_	_	_		_	_	_	_	_	_		_

^{*} OPTIONAL(If Needs are existing)

●ED Copper Foil

	#EB copport on																
Copper Foil		Film Thickness											Unit: mils (mm)				
		Sheet Type Max 610mm(MD) x 510mm(TD) Roll Type W=250mm, 500										, 500n	mm				
Thic	kness	0.5 (0.01)	0.8 (0.02)	1.0 (0.03)	2.0 (0.05)	3.0 (0.08)	4.0 (0.10)	5.0 (0.13)	6.0 (0.15)	0.5 (0.01)	0.8 (0.02)	1.0 (0.03)	2.0 (0.05)	3.0 (0.08)	4.0 (0.10)	5.0 (0.13)	6.0 (0.15)
-	(2µm)					_	_	_	_	_	_		•	_	_	_	_
1/6oz	(6µm)					_	_	_	_	_	_			_	_	_	_
1/4oz	(9µm)	_								_	_	_	_	_	_	_	_
1/3oz	(12µm)	-								_	_			_	_	_	_
1/2oz	(18µm)	-									_			_	_	_	_
1oz	$(35\mu m)$	_									_			_	_	-	_

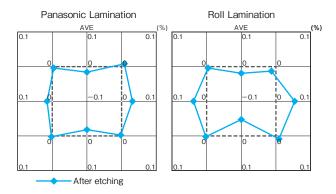
General Properties	R-F775				
Item	Unit	Condition	Typical value		
Surface resistance	ΜΩ	C-24/23/50	1×10 ¹⁵		
Dielectric constant(Dk) (1MHz)	_	C-24/23/50	3.2		
Dissipation factor(Df) (1MHz)	_	C-24/23/50	0.002		
Solder heat resistance	_	E-1/135 288°C solder float for 1min.	No abnormality		
Moisture heat resistance	_	C-96/40/90 260°C solder float for 1min.	No abnormality		
Peel strength	N/mm	C-24/23/50	1.3		
RA: 0.018mm(18µm)	N/ mm	260℃ solder float for 5sec.	1.3		
Flammability(UL method)	_	A+E-168/70	94V-0		
Tensile modulus	GPa	C-24/23/50	7.1		
		HCI 2mol/ℓ 23°C 5min.			
Chemical resistance	_	NaOH 2mol/ℓ 23°C 5min.	No abnormality		
		IPA 23℃ 5min.			
		After etching MD direction	0.030		
Dimensional stability	%	After etching TD direction	0.037		
Dimensional stability	70	After E-0.5/150 MD direction	0.022		
		After E-0.5/150 TD direction	0.027		

Note: The sample thickness is RA copper foil $18\mu\mathrm{m}$, film $25\mu\mathrm{m}$.

Note: The above test methods are in accordance with JIS C 6481 other than the cases flammability is with UL 94.

■Characteristic graph(reference value)

Dimensional stability



● Frequency dependence of dielectric property(IPC-TM650 2.5.5.5)

	Condition	1GHz	2.5GHz	5GHz	10GHz
Dielectric constant	А	3.2	3.2	3.2	3.2
(Dk)	C-96/40/96	3.3	3.3	3.2	3.2
Dissipation factor	А	0.002	0.002	0.002	0.003
(Df)	C-96/40/96	0.002	0.002	0.003	0.003